Search	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/690,112	BEZ ET AL.
Examiner	Art Unit
Patrick Hamo	3746

SEARCHED				
Class	Subclass	Date	Examiner	
417	62	3/23/2007	PH	
417	250	3/23/2007	PH	
417	251	3/23/2007	PH	
417	254	3/23/2007	PH	
417	255	3/23/2007	PH	
417	440	3/23/2007	PH	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
attached in	search, see nterference history	3/23/2007	PH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
417/62, 254, 255 and 440 updated as previously recommended by C Freay	3/23/2007	PH	
417/250 and 251 recommended by C Freay	3/23/2007	PH	
inventor name search: Eckhard Bez, Stefan Zabeschek	3/23/2007	РН	